

# Multiresolution analysis of point processes and statistical thresholding for Haar wavelet-based intensity estimation

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# Abstract

We take a wavelet-based approach to the analysis of point processes and the estimation of the first-order intensity under a continuous-time setting. A Haar wavelet multiresolution analysis is formulated which motivates the definition of homogeneity at different scales of resolution, termed *J*-th level homogeneity. Further to this, the activity in a point process' first-order behaviour at different scales of resolution is also defined and termed *L*-th level innovation. Likelihood ratio tests for both these properties are proposed with asymptotic distributions provided, even when only a single realization is observed. The test for *L*-th level innovation forms the basis for a collection of statistical strategies for thresholding coefficients in a wavelet-based estimator of the intensity function. These thresholding strategies outperform the existing local hard thresholding strategy on a range of simulation scenarios. This methodology is applied to NetFlow data, characterizing multiscale behaviour on computer networks.

**Keywords** Wavelets  $\cdot$  Multiresolution analysis  $\cdot$  Poisson process  $\cdot$  Likelihood ratio test  $\cdot$  Statistical thresholding

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# 1 Introduction

The development of wavelet theory has been one of the most significant advances in signal and image processing. Wavelets' ability to decompose an object at different scales makes them ideal for understanding underlying structures in random processes. Based on their success in analysing time series (Percival and Walden 2000), there has been an ever increasing interest in applying wavelets to point processes (e.g. Brillinger 1997; Cohen 2014). Representing a point process as N(A), a random integer indicating the number of events that have occurred in the set  $A \subset \mathbb{R}$ , one may use the notation N(t) to be equal to N((0, t]) for t > 0, -N((t, 0]) for t < 0and N(0) = 0 (Daley and Vere-Jones 1988). Wavelets have most commonly been used to estimate the first-order intensity (rate) function  $\lambda : \mathbb{R} \to \mathbb{R}_+$  defined as  $\lambda(t) = dE\{N\}/dt$ . This is based on the fact we can represent any  $L^2(\mathbb{R})$  function as a linear combination of basis functions. Namely, for some  $j_0 \in \mathbb{Z}$  and an orthogonal wavelet basis generated by father and mother pair  $(\phi, \psi)$ ,

$$\lambda(t) = \sum_{k \in \mathbb{Z}} \alpha_{j_0,k} \phi_{j_0,k}(t) + \sum_{j \ge j_0} \sum_{k \in \mathbb{Z}} \beta_{j,k} \psi_{j,k}(t)$$
(1)

where  $\phi_{j_0,k}(x) = 2^{j_0/2} \phi(2^{j_0}x - k)$  and  $\psi_{j,k}(x) = 2^{j/2} \psi(2^{j_k}x - k)$ , provided  $\lambda \in L^2(\mathbb{R})$ . To estimate  $\lambda$ , the task becomes estimating the set of coefficients  $\{\alpha_{j_0,k} \equiv \langle \lambda, \phi_{j_0,k} \rangle; k \in \mathbb{Z}\}$  and  $\{\beta_{j,k} \equiv \langle \lambda, \psi_{j,k} \rangle; j \ge j_0, k \in \mathbb{Z}\}$ , where  $\langle f_1, f_2 \rangle = \int_{\mathbb{R}} f_1(t) f_2^*(t) dt$  is the usual inner product on  $L^2(\mathbb{R})$  and  $f_2^*$  is the complex conjugate of  $f_2$ . This can be achieved by computing the stochastic integrals  $\hat{\alpha}_{j_0,k} = \int_{\mathbb{R}} \phi_{j_0,k}(t) dN(t) = \sum_{\tau_i \in \mathcal{E}} \phi_{j_0,k}(\tau_i)$  and  $\hat{\beta}_{j,k} = \int_{\mathbb{R}} \psi_{j,k}(t) dN(t) = \sum_{\tau_i \in \mathcal{E}} \psi_{j,k}(\tau_i)$ , where  $\mathcal{E}$  is the set of random event times of the process. Both  $\hat{\alpha}_{j_0,k}$  and  $\beta_{j,k}$  can easily be shown to be unbiased estimators of  $\alpha_{j_0,k}$  and  $\beta_{j,k}$ , respectively. Restricting the wavelet reconstruction up to some maximum resolution  $J \ge j_0$  in (1), one can construct the estimator

$$\hat{\lambda}^{J}(t) = \sum_{k \in \mathbb{Z}} \hat{\alpha}_{j_{0},k} \phi_{j_{0},k}(t) + \sum_{j=j_{0}}^{J} \sum_{k \in \mathbb{Z}} \hat{\beta}_{j,k} \psi_{j,k}(t)$$
(2)

which is asymptotically unbiased as  $J \to \infty$  under standard regularity assumptions on *N* (de Miranda and Morettin 2011). As in the classical wavelet regression setting (Donoho 1993), or when using wavelets to estimate probability density functions (Härdle et al. 1998), it is then typical that shrinkage or thresholding procedures are applied to the coefficients to reduce the variance of the estimator  $\hat{\lambda}^J$ .

Estimating the intensity of a point process has of course been addressed numerous times in either parametric (e.g. Rathbun and Cressie 1994) or nonparametric methods (e.g. Aalen 1978; Ramlau-Hansen 1983; Helmers and Zitikis 1999; Patil and Wood 2004; Brillinger 2012). In the specific case of wavelet-based estimation, a nonparametric method, the approaches can be split into discrete-time and continuous-time methods. Discrete-time methods (e.g. Timmermann and Nowak 1999; Kolaczyk 1999; Kolaczyk and Dixon 2000; Fryzlewicz and Nason 2004) typically apply a discrete wavelet transform (DWT) to the aggregated process { $N_t$ ;  $t \in \mathbb{Z}$ },

where  $N_t \equiv N(t + 1) - N(t)$  and then perform a shrinkage procedure. Besbeas et al. (2004) offer a comprehensive review of discrete-time methods and provide a simulation study comparing various thresholding schemes.

Under the continuous-time framework, the setting of this paper, Brillinger (1997) proposes the estimator in (2), as well as an estimator for the second-order intensity. The shrinkage procedure  $\hat{\beta}_{j,k} \to w(\hat{\beta}_{j,k}/s_{j,k})$  is proposed where  $s_{j,k}$  is an estimate of the standard error in  $\hat{\beta}_{j,k}$  and  $w(u) = (1 - u^{-2})_+$  is the Tukey function. Although applied to California earthquake data, the properties of the estimator are not studied in any detail. de Miranda (2008) offers the first proper treatment of the continuoustime formulation, providing the characteristic and density functions for the estimators of the coefficients  $\{\alpha_{i_0,k}; k \in \mathbb{Z}\}$  and  $\{\beta_{j,k}; j \ge j_0, k \in \mathbb{Z}\}$  in terms of the basis  $(\phi, \psi)$  under Haar wavelets as well as any continuous compactly supported wavelet of known closed form. This result is theoretically interesting but cannot be readily exploited as wavelets that fulfil all these criteria are rare and exotic. This work is extended in de Miranda and Morettin (2011) to provide first- and second-order moments for the linear (no thresholding) intensity estimator for any compactly supported wavelet of known closed form. With  $\mathbb{1}_{A}(x)$  representing the characteristic function of the set Α, they also propose а hard threshold  $\hat{\beta}_{j,k} \to \hat{\beta}_{j,k} (1 - \mathbb{1}_{[-\omega s_{i,k}, \omega s_{i,k}]}(\hat{\beta}_{j,k})) \ (\omega \text{ typically set to 3}), \text{ but it is given little treatment.}$ Further thresholding procedures in continuous time have been proposed in Bigot et al. (2013) under a Meyer wavelet basis and in Reynaud-Bouret and Rivoirard (2010) under any biorthogonal wavelet basis. Both of these estimators are shown to achieve near-optimal performance in the asymptotic setting that M, the number of observed independent realizations of the point process, goes to infinity. Further, the thresholding procedure of Revnaud-Bouret and Rivoirard (2010) does not require a compactly supported and bounded intensity to achieve asymptotic optimality. However, both thresholds are proportional to log(M) and are therefore only nonzero when M > 1, which questions their applicability to practical situations where one may only ever be able to observe a single realization. A thresholding procedure that can be applied in the M = 1 setting and for which the statistical properties are still tractable is therefore clearly desirable.

In this paper, we go beyond solely estimating the intensity and provide methodology for characterizing the multiscale properties of the point process. We consider a wavelet-based multiresolution analysis of a temporal point process, the motivation of which is both theoretical and practical. We demonstrate properties such as homogeneity can be explored and characterized through a multiresolution approach. We further propose statistical thresholding procedures for estimating the intensity in a data-driven way. Statistical thresholding has previously been considered in Abramovich and Benjamini (1995) in the classical wavelet regression setting. Here, we adapt it for point processes and show it is capable of providing estimates with just a single realization of the process (M = 1), while being grounded in a statistically principled and tractable framework.

In Sect. 2, we provide a background to wavelet estimation of point process intensities. We extend existing results to show that the linear wavelet estimator of  $\lambda$  has a scaled Poisson distribution under a Poisson process and the Haar wavelet basis. Then in Sect. 3 we develop the theoretical framework for a wavelet-based multiresolution analysis of a point process. Considering the first-order properties of a point process to be due to activity on different scales, under the Haar basis we define different levels of homogeneity, which we term *J*-th level homogeneity in reference to the particular scale *J* at which we are analysing the point process. We provide a likelihood ratio test (LRT) for these different levels of homogeneity for the class of Poisson processes, providing the asymptotic distribution for the LRT statistic under the null hypothesis. We then consider a further test for whether the intensity function exhibits activity at a particular scale, which we term *L*-th level innovation. Again, we provide a LRT for this property for the class of Poisson processes under the Haar wavelet basis.

In Sect. 4, we demonstrate how the LRT for *L*-th level innovation can be used as a method of statistical thresholding for wavelet coefficients, for which we propose three different forms: local, intermediate and global. Importantly, we demonstrate that under our LRT framework increasing *M* and increasing the intensity of the process are equivalent to one another, and hence indistinguishable in the asymptotic analysis. We are therefore able to use the asymptotic distributions to draw reliable inference and threshold the intensity in the M = 1 setting. We provide a comprehensive simulation study comparing the three different statistical thresholding procedures presented in this paper with the hard thresholding procedure given in de Miranda and Morettin (2011). We demonstrate that one or more of the proposed statistical thresholding procedures outperform this hard thresholding in almost all circumstances. In Sect. 5, we apply the presented methodology to real NetFlow data. In doing so, we demonstrate its effectiveness at revealing and characterizing multiscale behaviour on computer networks which could have a powerful impact in cyber-security, among other applications.

Further discussion on the LRTs, including boundary cases, can be found in Supplementary Material Section S1; all proofs are provided in Supplementary Material Section S2, and results of a comprehensive simulation study can be found in Supplementary Material Section S3, with a link to access the MATLAB code written to replicate the simulation study.

We focus on the Haar wavelet basis as the notion of homogeneity and innovation within its associated multiresolution analysis is natural, interpretable and tractable, albeit producing discontinuous estimates. Extensions of *J*-th level homogeneity and *L*-th level innovation to other wavelet bases are proposed in Supplementary Material Section S4. Similarly, a discussion on how the estimation and statistical thresholding procedures presented in this paper can be extended to Daubechies D4 wavelets can be found in Supplementary Material Section S4.1.

# 2 Wavelets and estimation of the intensity

In this section, we provide a brief background to wavelet estimation of point process intensities. We will restrict ourselves to simple point processes with no fixed atoms, i.e. point processes that satisfy  $N({t}) \in {0, 1}$  almost surely for all  $t \in \mathbb{R}$ , and the probability of observing a point at any pre-specified location is zero.

#### 2.1 Wavelets and multiresolution analysis

We summarize here essential definitions and results on wavelets that need to be stated prior to their application to the intensity function. The theory presented here follows the work of Meyer (1992).

**Definition 1** A multiresolution approximation of  $L^2(\mathbb{R}^n)$  is an increasing sequence  $V_i$ ,  $j \in \mathbb{Z}$ , of closed linear subspaces of  $L^2(\mathbb{R}^n)$  with the following properties:

- 1.  $\bigcap_{j=-\infty}^{\infty} V_j = \{0\}, \quad \bigcup_{j=-\infty}^{\infty} V_j \text{ is dense in } L^2(\mathbb{R}^n);$ 2. for all  $f \in L^2(\mathbb{R}^n)$  and  $j \in \mathbb{Z}, f(\cdot) \in V_j \iff f(2\cdot) \in V_{j+1};$
- 3. for all  $f \in L^2(\mathbb{R}^n)$  and  $k \in \mathbb{Z}^n$ ,  $f(\cdot) \in V_0 \iff f(\cdot k) \in V_0$ ;
- 4. there exists a function  $g \in V_0$ , such that the sequence  $g(\cdot k), k \in \mathbb{Z}^n$ , is a Riesz basis of the space  $V_0$ .

It is also shown in Meyer (1992) that for a Riesz basis  $g(\cdot - k), k \in \mathbb{Z}^n$  of  $V_0$ , the sequence  $\phi(\cdot - k), k \in \mathbb{Z}^n$  defined by  $\Phi(\xi) = G(\xi)(\sum_{k \in \mathbb{Z}^n} |G(\xi + 2k\pi)|^2)^{-1/2}$  is the canonical orthonormal basis of  $V_0$ , where  $\Phi$  and G are the Fourier transforms of  $\phi$ and g, respectively.  $\phi$  is called either the father wavelet or scaling function. In this paper, we are concerned with point processes on the real line, and therefore we focus on the space  $L^2(\mathbb{R})$ . Defining  $W_i$  to be the orthogonal complement of  $V_i$  in  $V_{i+1}$ , Definition 1 allows us to write

$$L^{2}(\mathbb{R}) = \overline{V_{j_{0}} \oplus \bigoplus_{j=j_{0}}^{\infty} W_{j}}$$
 or  $L^{2}(\mathbb{R}) = \overline{\bigoplus_{j=-\infty}^{\infty} W_{j}}.$  (3)

The spaces  $V_i$  each have the basis  $\{\phi_{i,k}(x) := 2^{j/2}\phi(2^jx - k), k \in \mathbb{Z}\}$  and are called the approximation spaces. The spaces  $W_i$  are called detail spaces, and each has the orthonormal basis  $\{\psi_{i,k}(x) := 2^{j/2}\psi(2^jx - k), k \in \mathbb{Z}\}$ , where  $\psi(x)$  is called the mother wavelet and is constructed from the father wavelet. The mappings  $f(\cdot) \rightarrow 2^{j/2} f(2^j \cdot -k)$  are called dyadic transformations. Consequently, a fundamental result from (3) is that for any  $j_0 \in \mathbb{Z}$ , the set  $\{\phi_{i_0,k}; k \in \mathbb{Z}\} \cup \{\psi_{j,k}; j \ge j_0, k \in \mathbb{Z}\}$ forms an orthonormal basis for  $L^2(\mathbb{R})$ . Furthermore, for any  $j_0 \in \mathbb{Z}$  a function  $f \in L^2(\mathbb{R})$  can be decomposed as

$$f(x) = \sum_{k \in \mathbb{Z}} \langle f, \phi_{j_0, k} \rangle \phi_{j_0, k}(x) + \sum_{j \ge j_0} \sum_{k \in \mathbb{Z}} \langle f, \psi_{j, k} \rangle \psi_{j, k}(x).$$
(4)

This identity, which illustrates the idea of multiscale analysis, will be used to decompose the first-order intensity of a point process. In practice, a function  $f \in L^2(\mathbb{R})$  is often approximated by its projection onto a specific approximation space  $V_J = V_{j_0} \bigoplus \bigoplus_{i=i_0} W_j$ , with  $J > j_0$ . Expansion (4) is then reduced to:

$$f^{J}(x) = \sum_{k \in \mathbb{Z}} \langle f, \phi_{J,k} \rangle \phi_{J,k}(x) = \sum_{k \in \mathbb{Z}} \langle f, \phi_{j_{0},k} \rangle \phi_{j_{0},k}(x)$$
  
+ 
$$\sum_{j=j_{0}}^{J-1} \sum_{k \in \mathbb{Z}} \langle f, \psi_{j,k} \rangle \psi_{j,k}(x).$$
(5)

As we increase J, the function  $f^J \in V_J$  approximates f with ever increasing accuracy such that  $||f^J - f||_2 \to 0$  as  $J \to \infty$ , where  $|| \cdot ||_2 = \sqrt{\langle \cdot, \cdot \rangle}$  is the  $L^2$  norm.

#### 2.2 Continuous-time wavelet estimator of the intensity

Consider a point process with a piecewise continuous intensity function  $\lambda \in L^2(\mathbb{R})$ , typically restricted to a finite length observation window [0, *T*). We write the following wavelet expansion for this intensity (de Miranda and Morettin 2011; Brillinger 1997):

$$\lambda(t) = \sum_{k \in \mathbb{Z}} \alpha_{j_0,k} \phi_{j_0,k}(t) + \sum_{j \ge j_0} \sum_{k \in \mathbb{Z}} \beta_{j,k} \psi_{j,k}(t), \tag{6}$$

where  $j_0 \in \mathbb{Z}$  is fixed and called the coarse resolution level,  $\alpha_{j_0,k} = \langle \lambda, \phi_{j_0,k} \rangle$ and  $\beta_{j,k} = \langle \lambda, \psi_{j,k} \rangle$ . We are required to estimate the coefficients  $\alpha_{j_0,k}$  and  $\beta_{j,k}$  which we do so with  $\hat{\alpha}_{j_0,k} = \int \phi_{j_0,k}(t) dN(t) = \sum_{\tau_i \in \mathcal{E}} \phi_{j_0,k}(\tau_i)$  and  $\hat{\beta}_{j,k} = \int \psi_{j,k}(t) dN(t) = \sum_{\tau_i \in \mathcal{E}} \psi_{j,k}(\tau_i)$ , where  $\mathcal{E} = \{\tau_i, 1 \le i \le N(T)\}$  are the event times for one realization of a point process *N* on the time interval [0, *T*). The observation window [0, *T*) is often arbitrary or dictated by the application of interest. Hence, the general linear estimator of the intensity function based on its wavelet expansion is:

$$\widehat{\lambda}(t) = \sum_{k \in \mathbb{Z}} \widehat{\alpha}_{j_0,k} \phi_{j_0,k}(t) + \sum_{j \ge j_0} \sum_{k \in \mathbb{Z}} \widehat{\beta}_{j,k} \psi_{j,k}(t).$$
(7)

In the temporal case, dN(t) can also denote the differential process N(t + dt) - N(t). For a compactly supported wavelet function, Campbell's theorem (Daley and Vere-Jones 1988, Chapter 6) gives us

$$\begin{split} & \mathrm{E}\{\widehat{\alpha}_{j_0,k}\} = \int \phi_{j_0,k}(t) E\{\mathrm{d}N(t)\} = \int \phi_{j_0,k}(t)\lambda(t)\mathrm{d}t = \alpha_{j_0,k}\\ & \mathrm{E}\{\widehat{\beta}_{j,k}\} = \int \psi_{j,k}(t) E\{\mathrm{d}N(t)\} = \int \psi_{j,k}(t)\lambda(t)\mathrm{d}t = \beta_{j,k}, \end{split}$$

showing the coefficient estimators to be unbiased. This is a linear estimator as it involves no shrinkage of the coefficients.

For obvious computational reasons, we cannot in practice use an infinite wavelet basis to reconstruct the intensity (the intensity may only be fully reconstructed when we know that its decomposition is actually finite). Therefore, we firstly have to choose a maximum resolution level J. This maximum level plays a role in the bias-variance trade-off of the estimator. Low values of J result in a



**Fig. 1** Representation of three different wavelets. The Haar wavelet has a compact support and a closed-form expression, the Daubechies D4 wavelet has a compact support only and the Meyer wavelet has a closed-form expression only

smooth (high bias, low variance) estimator, whereas large values of J result in a noisy (low bias, high variance) estimator. The linear estimator then becomes the estimator of the projection of  $\lambda$  onto the space  $V_J = V_{j_0} \bigoplus \bigoplus_{i=j_0}^{J-1} W_j$ , and is denoted  $\hat{\lambda}^{J}$  from now on. In the case of linear estimation (no thresholding), the choice of  $j_0$  is not relevant since it suffices to estimate the father wavelet coefficients from the approximation space  $V_J$ . Also, with compactly supported wavelets and events restricted to a finite length observation window [0, T), the subset of translation indexes  $k \in \mathbb{Z}$  satisfying  $\hat{\beta}_{i,k} \neq 0$  is finite. A nonlinear estimator is obtained by adding a coefficient shrinkage term, determined from a thresholding strategy. The use of shrinkage methods in the classical wavelet regression setting is well studied (e.g. Donoho et al. 1995 and is used as a smoothing method to suppress contributing terms from fine scales which typically contain noise. For point process intensity estimation, while we do not have a noise term per se, shrinkage strategies are again desirable for smoothing, with fine scale terms typically having high variance. Thresholding also requires to choose the coarsest level of resolution  $j_0$ , ideally to some optimal value, since  $j_0$  is also involved in the bias-variance trade-off. When  $j_0 \ge 0$ , all the mother wavelet coefficients at the coarse levels  $0 \le j \le j_0$  are kept. Donoho and Johnstone (1994) and Donoho et al. (1995) typically use  $j_0 = 5$ . From a further simulation study in Abramovich and Benjamini (1995), it is suggested that the choice for  $j_0$  should be dependent on both the smoothness of the estimated function and the noise level.

When reconstructing the intensity of a point process, we have two desirable properties for a wavelet function. The first is that it should have a closed-form expression; it will be shown that this is required to compute the continuous linear estimator of the intensity function in an exact fashion, although in general not necessary for wavelet analysis and reconstruction of intensities. Second, the wavelet should be compactly supported; this is because invariably we can only observe the point process on a finite interval and therefore compactly supported wavelets allow us to only consider a finite set of dyadic translations. In Fig. 1, we show three examples of wavelet families; these are the Haar, Daubechies D4 and Meyer wavelets. Each family exhibits either one or both characteristics.

#### 2.2.1 Haar estimator

The Haar mother and father wavelets are defined as

$$\psi(t) = \begin{cases} 1 & \text{if } 0 \le t < 1/2 \\ -1 & \text{if } 1/2 \le t < 1 \\ 0 & \text{otherwise} \end{cases} \text{ and } \phi(t) = \begin{cases} 1 & \text{if } 0 \le t < 1 \\ 0 & \text{otherwise} \end{cases}$$

These wavelets can be extended to the support [0, T] with an orthonormality preserving rescaling  $\psi_T(t) = T^{-1/2}\psi(t/T)$  and dyadic transforms of the type  $\psi_{T,j,k}(t) = 2^{j/2}\psi_T(2^jt - kT)$ . Henceforth, we will drop the subscript  $_T$  and assume all wavelets are scaled for the support [0, T]. At each scale J, the supports of  $\phi_{J,k}$  and  $\psi_{J,k}$  are of length  $T/2^J$ . Now, consider a point process N on [0, T). By construction, the interiors of Haar wavelets' supports are disjoint across all translations for a fixed scale, which implies that we only need  $2^J$  wavelet coefficients when reconstructing on  $V_J$ , when  $J \ge 0$ . The linear estimator of the intensity function based on its Haar wavelet expansion becomes:

$$\hat{\lambda}^{J}(t) = \sum_{k=0}^{2^{j_{0}}-1} \hat{\alpha}_{j_{0},k} \phi_{j_{0},k}(t) + \sum_{j=j_{0}}^{J-1} \sum_{k=0}^{2^{j}-1} \hat{\beta}_{j,k} \psi_{j,k}(t) = \sum_{k=0}^{2^{j}-1} \hat{\alpha}_{J,k} \phi_{J,k}(t),$$

for  $j_0 \ge 0, J \ge j_0$ .

**Remark 1** Under the Haar wavelet basis, at scale  $J \ge 0$  and a translation  $0 \le k \le 2^J - 1$  we have  $\alpha_{J,k} = \frac{1}{\sqrt{2}} (\alpha_{J+1,2k} + \alpha_{J+1,2k+1}).$ 

See proof in Supplementary Material S2.1. The linear estimator based on the Daubechies D4 wavelets is discussed in Supplementary Material Section S4.1.1. In Fig. 2, we illustrate how the linear estimator behaves on an example intensity model with Haar and Daubechies D4 wavelets.



Fig. 2 Estimation of an example intensity with Haar and D4 wavelets obtained with an average over 1000 realizations of a point process on [0, 3]. We choose J = 3 here. The intensity is the sum of a triangular and a sine function

# 2.2.2 Distribution of $\hat{\lambda}'$

In the case of Haar wavelets, we are able to derive the distribution of the estimator  $\hat{\lambda}^{J}$ . The approximation space of interest,  $V_{J}$ , naturally induces a subdivision  $S_{J} = \left\{s_{k}^{J}\right\}_{k=0}^{2^{J}-1}$  of the interval [0, *T*). The elements of this subdivision,  $s_{k}^{J} = [T\frac{k}{2^{J}}, T\frac{k+1}{2^{J}})$ , are the nonzero intervals of the Haar wavelets at scale *J* and form  $2^{J}$  disjoint subintervals [0, *T*). The Haar reconstruction of the intensity  $\lambda^{J}$  and its linear estimator  $\hat{\lambda}^{J}$  are piecewise constant functions, with forms  $\lambda^{J}(t) = \sum_{k=0}^{2^{J}-1} \lambda_{k}^{J} \mathbb{1}_{s_{k}^{J}}(t)$  and  $\hat{\lambda}^{J}(t) = \sum_{k=0}^{2^{J}-1} \hat{\lambda}_{k}^{J} \mathbb{1}_{s_{k}^{J}}(t)$ , respectively. Hence, we can establish the exact distribution for this estimator under a Poisson process model.

**Proposition 1** Under the Haar wavelet basis and for an inhomogeneous Poisson process N of intensity  $\lambda$  on [0, T),  $\hat{\lambda}_0^J, \ldots, \hat{\lambda}_{2^J-1}^J$  are independent random variables distributed as

$$\widehat{\lambda}_k^J \sim \frac{2^J}{T} \operatorname{Pois}(\mu_k^J), \quad 0 \le k \le 2^J - 1,$$

where  $\mu_k^J = \int_{s_k^J} \lambda(t) dt$ .

The proof can be found in Supplementary Material S2.2. The result can also naturally be extended to any other point process with a square integrable intensity function for which the distribution of the event counts in any time interval is known (e.g. a binomial point process). It follows that  $E\{\hat{\lambda}_k^J\} = \lambda_k^J = \frac{2^J}{T}\mu_k^J$ , for all  $0 \le k \le 2^J - 1$ . We will now use Proposition 1 to develop likelihood ratio tests for two newly defined multiscale properties of a Poisson process.

# 3 A new testing protocol for multiscale properties of Poisson processes

In this section, we will develop the theoretical framework for a wavelet-based multiresolution analysis of a point process. Considering the first-order properties of a point process to be due to activity on different scales, under the Haar basis we define different levels of homogeneity under a multiresolution framework. We call this *J*-th level homogeneity, and provide a likelihood ratio test for it for the class of Poisson processes.

Under a compactly supported wavelet family, we then consider a more general setting to describe any activity of the intensity function at a particular scale, which we term *L*-th level innovation. We provide a likelihood ratio test for this property for the class of Poisson processes under the Haar basis. In Sect. 4, we will demonstrate how this test can be used as a method of thresholding coefficients in our wavelet estimator of the intensity function. In this section, it will be always assumed that  $\lambda \in L^2(\mathbb{R})$ .

# 3.1 Global behaviour: J-th level homogeneity

We use the Haar wavelet basis (rescaled if T is different than 1), because of its intuitive interpretation, its simplicity to implement and its amenability to statistical analysis. We consider the projection of the intensity on the Haar approximation space  $V_J = V_{j_0} \bigoplus \bigoplus_{j=j_0}^{J-1} W_j$ . With Haar wavelets, the reconstruction of the intensity at scale *J* is a piecewise constant function, and hence we can define a wavelet reconstruction vector  $(\lambda_0^J, \lambda_1^J, \dots, \lambda_{2^J-1}^J)^T$  where  $\lambda_k^J$  is the value of  $\lambda^J$  on the subinterval  $s_k^J \in S_J$ ,  $k = 0, \dots, 2^J - 1$ . We use this formulation to define a property we call *J*-th level homogeneity.

**Definition 2** A point process *N* on [0, *T*) with intensity  $\lambda$  is considered **level** *J* **homogeneous** if the reconstruction of the intensity at resolution *J* with Haar wavelets, or its projection on  $V_J$ , is constant on [0, *T*). That is,  $\lambda_0^J = \lambda_1^J = \cdots = \lambda_{2^J-1}^J$ .

*J*th-level homogeneity was introduced in Taleb and Cohen (2016) in terms of the projection of the intensity on  $V_{J+1}$ . We propose that it is instead more convenient to base it on  $V_J$ , i.e. every point process is level 0 homogeneous as the projected intensity  $\lambda_0^0$  on  $V_0$  is always a constant on [0, *T*). The concept of *J*-th level homogeneity goes side by side with the idea of a Haar multiresolution analysis of the intensity function, providing a natural way of studying on what scales the intensity function appears constant and hence the point process homogeneous, and on what scales the intensity function exhibits variability. If we define  $H_J$  as the class of level *J* homogeneous point processes, we have  $H_J \supset H_{J+1}$ . Indeed we know from Remark 1 that  $\alpha_{J,k} = \frac{1}{\sqrt{2}}(\alpha_{J+1,2k} + \alpha_{J+1,2k+1})$  for Haar wavelets, and therefore  $\lambda_0^J = \lambda_1^J = \cdots = \lambda_{J-1}^J$  if  $\alpha_{J+1,0} = \alpha_{J+1,1} = \cdots = \alpha_{J+1,2^{J+1}-1}$ .

**Proposition 2** Let N be a point process with a locally square integrable intensity  $\lambda$ . Then  $\lambda$  is constant almost everywhere on [0, T) (i.e.  $\lambda(t) = \lambda_0^0 = \frac{1}{T} \int_0^T \lambda(t) dt$  almost everywhere) if and only if  $N \in H_J$  for all  $J \ge 0$ .

See Supplementary Material S2.3 for the proof. To avoid any confusion, we say that a point process with intensity  $\lambda$  is strictly homogeneous on [0, T) when  $\lambda(t) = \lambda_0^0$  for all  $t \in [0, T)$ . Proposition 2 illustrates how strict homogeneity can be loosely interpreted as the limit extension of *J*th-level homogeneity. Furthermore, Definition 2 naturally leads us to define *J*th-level inhomogeneity.

**Definition 3** A point process N on [0, T) with intensity  $\lambda$  is considered **level** J inhomogeneous if it is level J - 1 homogeneous and not level J homogeneous.

We immediately remark that a level J inhomogeneous point process is not level j homogeneous for all  $j \ge J$ . Since J-th level homogeneity and inhomogeneity are based on the projection of the intensity function on the Haar approximation space  $V_j$ , they are descriptors of the first-order behaviour of the point process when viewed at a particular scale. For instance, a point process may appear homogeneous when

viewed at a coarse scale but show inhomogeneity when viewed at a finer resolution. An extension of *J*-th level homogeneity to other wavelets is proposed in Supplementary Material S4.

#### 3.2 Testing J-th level homogeneity

As the scope of this work is to analyse point processes in a multiscale fashion, we are not interested in testing the strict homogeneity of a Poisson process, which is the limit case for Definition 2 and has been thoroughly addressed in previous studies (e.g. Bain et al. 1985; Ng and Cook 1999). We are instead aiming to statistically determine the resolution level where inhomogeneous behaviour appears. Recall that the choice of Haar wavelets implies that the wavelet reconstruction  $\lambda^J$  of the intensity  $\lambda$ , as well as the intensity estimator  $\hat{\lambda}^J$ , are piecewise constant functions on the dyadic partition  $S_J$ . Although a piecewise analysis has also been carried out in Fierro and Tapia (2011) as a basis for a similar LRT, the wavelet approach presented here gives a natural, multiresolution scheme for defining the subdivision of the process. We begin by considering the LRT for equal means of scaled Poisson distributions, the results of which we can then utilize to test *J*-th level homogeneity of Poisson processes. This provides a comprehensive and rigorous treatment of the ideas first proposed in Taleb and Cohen (2016).

#### 3.2.1 LRT for equal means of scaled Poisson distributions

Let  $\mathbb{X} = \{\mathbf{X}_m\}_{m=1}^M$  be a set of iid scaled Poisson random vectors, each with independent components of form  $\mathbf{X}_m = (X_{m,i})_{i=1}^P$ ,  $X_{m,i} \sim \delta \text{Pois}(\mu_i)$ . The scale parameter  $\delta > 0$  is known and fixed so  $\mathbf{X}_m$  is parametrized by the vector  $(\mu_i)_{i=1}^P$ . We consider testing the null hypothesis  $H : \mu_1 = \cdots = \mu_P = \mu_c$  against the alternative hypothesis *K* that states *H* is not true. The LRT statistic is defined as

$$r = \frac{\sup_{\mu_c > 0} \mathcal{L}(\mathbb{X}; \mu_c, \dots, \mu_c)}{\sup_{\{\mu_i\}_{i=1}^{P}, \sum \mu_i > 0} \mathcal{L}(\mathbb{X}; \mu_1, \dots, \mu_P)},$$
(8)

where  $\mathcal{L}(X;\mu_1,\ldots,\mu_P)$  is the likelihood of the data X given parameter vector  $(\mu_i)_{i=1}^P$ .

**Proposition 3** Let  $R = -2 \log(r)$ , with *r* being the likelihood ratio statistic defined in (8). Then we have

$$R = 2M \sum_{i=1}^{P} \bar{\mu}_i \log\left(\frac{\bar{\mu}_i}{\bar{\mu}_c}\right),$$

where  $\bar{\mu}_c = \frac{1}{\delta M P} \sum_{i=1}^{P} \sum_{m=1}^{M} X_{m,i}$  is the maximum likelihood estimator (MLE) for  $\mu_c$ , the constant mean under the null hypothesis H, and  $\bar{\mu}_i = \frac{1}{\delta M} \sum_{m=1}^{M} X_{m,i}$  is the MLE for  $\mu_i$  (i = 1, ..., P), under the alternative hypothesis K.

See Supplementary Material S2.4 for the proof. If there exists at least one index *i* such that  $\bar{\mu}_i = 0$ , we use the convention  $0 \log(0) = 0$ . Further discussion on the absence of points within intervals can be found in Supplementary Material S1.2. Now, let  $d_H$  be the number of free parameters under the null hypothesis *H* and let  $d_K$  be the number of free parameters under the alternative hypothesis *K*, then under the null hypothesis and regularity conditions on the likelihood functions that are met here,  $R \rightarrow \chi^2_{d_K-d_H}$  as sample size  $M \rightarrow \infty$  (see Wilks 1938; Van der Vaart 2000). In this setting,  $d_K = P$  and  $d_H = 1$ . In practice, the M = 1 case is frequently encountered, and therefore we establish a more general and applicable result for the asymptotic distribution of *R*.

**Theorem 1** Let  $\mathbf{X}_1, \ldots, \mathbf{X}_M$   $(M \ge 1)$  be independent and identically distributed P dimensional random vectors where each  $\mathbf{X}_m = (X_{m,1}, \ldots, X_{m,P})^T$  is constructed from independent components  $X_{m,i} \sim \delta \operatorname{Pois}(\mu_i)$ . Let  $R = -2 \log(r)$  where r is the likelihood ratio statistic defined in (8). Then the distribution of statistic R is invariant to simultaneous changes in parameters M and  $\mu_i$  provided that all products  $\mu_i M$ ,

 $1 \le i \le P$ , remain constant. Furthermore, if  $\mu_1 = \cdots = \mu_P = \mu_c$ , then  $R \xrightarrow{d} \chi^2_{P-1}$  as  $\mu_c M \to \infty$ .

See Supplementary Material S2.6 for the proof<sup>1</sup>. It will now be shown that this result illustrates the practical advantage of Haar wavelets as it ensures that only one realization of the process is enough to conduct a LRT for *J*-th level homogeneity.

#### 3.2.2 LRT for J-th level homogeneity of a Poisson process

Now, let  $\{N_m, m = 1, ..., M\}$  be a collection of  $M \ge 1$  independent realizations of the same Poisson process N. Let  $\Lambda = \{\Lambda_m\}_{m=1}^M$  be the set of M independent random vectors where  $\Lambda_m = (\hat{\lambda}_{m,k}^J)_{k=0}^{2^J-1}$  is the vector of all subinterval estimates of the intensity from  $N_m$ . From Proposition 1,  $\Lambda_m$  is a vector of independent scaled Poisson random variables and is therefore parametrized by the vector  $(\lambda_k^J)_{k=0}^{2^J-1}$ . We look to test the null hypothesis H which states N is level J homogeneous, i.e.  $\lambda_0^J = \cdots = \lambda_{2^J-1} = \lambda_c^J$  for some  $\lambda_c^J > 0$ , against the alternative hypothesis K which states H is not true. The LRT statistic in this case is given as:

$$r^{J} = \frac{\sup_{\substack{\lambda_{c}^{J} > 0}} \mathcal{L}(\Lambda; \lambda_{c}^{J}, \dots, \lambda_{c}^{J})}{\sup_{\{\lambda_{k}^{J}\}_{k=0}^{2^{J-1}}, \sum \lambda_{k}^{J} > 0}} \mathcal{L}(\Lambda; \lambda_{0}^{J}, \dots, \lambda_{2^{J-1}}^{J})},$$

<sup>&</sup>lt;sup>1</sup> It has been shown in Feng et al. (2012) that the classic asymptotic distributional result for the test statistic *R* does not hold if we are restricting ourselves to the M = 1 case and low values of  $\mu_c$  ( $\mu_c \le 10$  in their study). This refutes the opposite claim in Brown and Zhao (2002), which possibly resulted from a confusion between the number of parameters *P* and the number *M* of independent realizations of the Poisson vector.



Fig. 3 Left: Haar wavelet reconstruction of a piecewise triangular intensity with  $V = 1, \xi = 0.1$  and T = 1 at resolutions  $J \in \{2, 3, 4, 5\}$ . Right: Empirical type 1 error (J = 2) and power  $(J \in \{3, 4, 5\})$  for this piecewise triangular intensity as a function of  $\lambda_0$ 

where  $\mathcal{L}(\Lambda; \lambda_0^J, \dots, \lambda_{2^J-1}^J)$  is the likelihood of the data  $\Lambda$  given parameter vector  $(\lambda_k^J)_{k=0}^{2^J-1}$ . Now using Proposition 3 we can write

$$R^{J} = -2\log(r^{J}) = 2\frac{M}{\delta^{J}}\sum_{k=0}^{2^{J}-1}\bar{\lambda}_{k}^{J}\log\left(\frac{\bar{\lambda}_{k}^{J}}{\bar{\lambda}_{c}^{J}}\right),$$

where  $\delta^J = 2^J/T$ , statistic  $\bar{\lambda}_c^J$  is the maximum likelihood estimator (MLE) of  $\lambda_c^J$ and  $\bar{\lambda}_k^J$  is the MLE for  $\lambda_k^J$  ( $k = 0, ..., 2^J - 1$ ), under the alternative hypothesis *K*. In this particular setting, we have  $d_K = 2^J$  and  $d_H = 1$ , giving *R* as asymptotically  $\chi^2$ distributed with  $2^J - 1$  degrees of freedom under the conditions of Theorem 1. We reject *J*-th level homogeneity at significance level  $\alpha$  if  $R > c_{\alpha}$  where  $c_{\alpha}$ , the critical value, is the upper  $100(1 - \alpha)\%$  point of the  $\chi^2_{2^{J-1}}$  distribution.

#### 3.2.3 Simulation study

Here, we demonstrate the LRT for *J*-th level homogeneity through simulations. We consider a class of inhomogeneous Poisson processes on a time interval [0, T). These processes share a similar piecewise triangular intensity represented in Fig. 3 and are defined as the following:

$$\lambda(t) = \lambda_0 \left( 1 + (-1)^{i(t)} \xi \left( \theta(t) - \frac{1}{2} \right) \right),$$

where  $i(t) \in \{0, \dots, 2^{V+1} - 1\}$  is the index of the subinterval  $s_{i(t)}^{V+1} = [\frac{i(t)}{2^{V+1}}T, \frac{i(t)+1}{2^{V+1}}T)$ in which *t* belongs, and  $\theta(t)$  is defined by  $t = (i(t) + \theta(t))T/2^{V+1}$ . The absolute value of the gradient is  $\xi \lambda_0 2^{V+1}/T$  and  $2^V$  is the number of "triangles". The intensity takes values between  $\lambda_0 \frac{2-\xi}{2}$  and  $\lambda_0 \frac{2+\xi}{2}$  and its mean value  $\lambda_0^0$  is the parameter  $\lambda_0 > 0$ . By construction, the quantity  $\mu_0^0 = \int_0^T \lambda(t)dt = T\lambda_0$  does not depend on *V*, the process is level V + 1 homogeneous and level V + 2 inhomogeneous. We set the significance level of our test at  $\alpha = 0.05$ , with M = 1, i.e. we observe just a single realization. The empirical type 1 error and power of the LRT (over 10,000 simulations) at different values of *J* are shown in Fig. 3 as a function of  $\lambda_0$ , with  $\lambda_0 \in [1000, 50,000]$ .

In the example represented in Fig. 3 where the process is level 2 homogeneous, the empirical type 1 error lies close to the 5% level as expected. When  $J \ge 3$ and J-th level homogeneity no longer holds, the empirical power converges to 1



**Fig. 4** *Left*: Empirical type 1 error (J = 2) and power  $(J \in \{3, 4, 5\})$  for the piecewise triangular intensity where  $\xi = \xi_0/\lambda_0$ , with  $\xi_0 = 1000$ . *Right*: Empirical type 1 error (J = 2) and power  $(J \in \{3, 4, 5\})$  for the piecewise triangular intensity where  $\xi = \xi_0/\sqrt{\lambda_0}$ , with  $\xi_0 = \sqrt{1000}$ 

when  $\lambda_0 \to \infty$ . This behaviour is expected as well. Indeed, this intensity model is proportional to  $\lambda_0$  and therefore its Haar reconstruction at any scale *J* satisfies  $\lambda_k^J \propto \lambda_0$  as well as  $\mu_k^J \propto \lambda_0$ . Since statistic  $R^J$  tends to infinity as *M* increases towards infinity when  $J \ge 3$  and a fixed  $\lambda_0$ , then the power of the LRT converges to 1. Hence, the observed convergence of the empirical power to 1 when *M* is fixed and  $\lambda_0$  increases towards infinity as ensured by Theorem 1. Similarly, the value of parameter  $\xi$  influences the speed of this convergence. Moreover, we note the power decreases as we increase *J* because the mass of the null distribution  $\chi_{2^J-1}^2$  is displaced to the right as *J* increases, making it harder for the test to distinguish between the two hypotheses.

We also consider two scenarios where the parameter  $\xi$  is now dependent on  $\lambda_0$  (variable ripple). The results for these two scenarios are given in Fig. 4. When  $\xi = \xi_0/\lambda_0$ , the power decreases as  $\lambda_0$  increases. Since  $\lambda(t)$  takes values in the interval  $\lambda_0 \frac{2-\xi}{2}$  and  $\lambda_0 \frac{2+\xi}{2}$ , the inhomogeneity from  $J \ge 3$  due to the structure of the intensity is less detectable by the LRT as its amplitude decreases too quickly with  $\xi$ . When the parameter  $\xi$  is instead equal to  $\xi_0/\sqrt{\lambda_0}$ , the power stays maximal for the values of  $\lambda_0$  considered in the simulation study. The amplitude of the intensity model decreases slowly enough as  $\lambda_0$  increases such that the inhomogeneity is always detected by the LRT.

#### 3.3 Local behaviour: L-th level innovation

In Sect. 2.1, we presented the decomposition  $L^2(\mathbb{R}) = \overline{V_{j_0} \oplus \bigoplus_{j=j_0}^{\infty} W_j}$  where  $W_j$  is the orthogonal complement of  $V_j$  in  $V_{j+1}$  and often called the detail or innovation space. With *J*-th level homogeneity we focused on the behaviour displayed on any space  $V_j$ , which brings together contributions from several resolutions. Projecting  $\lambda$  on  $W_j$  for increasing  $j \ge j_0$ , we explore the intensity function in progressively finer resolutions. To characterize this, we introduce the concept of *L*-th level innovation.

**Definition 4** Let *N* be a point process on [0, T) with a square integrable intensity  $\lambda$ . We say that *N* possesses a **level L innovation** under the Haar basis if and only if there exists at least one index  $k \in \mathbb{Z}$  such that  $\beta_{L,k} = \langle \lambda, \psi_{L,k} \rangle \neq 0$ .

Since a point process on [0, T) with constant intensity is level *J* homogeneous for all  $J \ge 0$ , it also displays no *L*-th level innovation irrespective of  $L \ge 0$ . With a constant intensity on observation window [0, T), wavelets with non-compact support will always produce an infinite number of nonzero wavelet coefficients and unbiasedness of their estimators is not guaranteed. Furthermore, compactly supported wavelets whose support is only partially contained within [0, T) will also admit nonzero wavelet coefficients. This is why we restrict ourselves to Haar wavelets in the definition of *L*-th level innovation. Extensions of *L*-th level innovation to other wavelets is considered in Appendix in ESM. We further comment that although defined according to a specific scale, *L*-th level innovation also has an inherent temporal component. The translation index of nonzero coefficients given by wavelets in  $W_L$  indicates the time localization of the corresponding innovation.

**Remark 2** For the Haar wavelet, there is the following equivalence:

- A point process N is level J homogeneous and possesses a level J innovation.
- A point process N is level J + 1 inhomogeneous.

This equivalence is immediate from applying Definitions 3 and 4 to the identity  $V_{J+1} = V_J \oplus W_J$ .

#### 3.4 Testing Lth-level innovation

We are now interested in testing for *L*-th level innovation based on Definition 4 using the null hypothesis *H*: "*A point process N possesses no L-th level innovation under a wavelet family* ( $\phi, \psi$ )". To do so, we consider the vector of empirical wavelet coefficients corresponding to the wavelet basis for  $W_L$ , which under the null hypothesis will be zero mean. As for *J*-th level homogeneity, we define a likelihood ratio test for *L*th-level innovation under the Poisson process model and Haar wavelets. This test will again be a special case of a more general setting for multivariate Poisson random variables.

If a point process is level J + 1 inhomogeneous, then such a test should take place for any given scale L > J (as by Remark 2 we know there already exists an innovation at level J). Consider a subdivision  $S_{L+1}$  of [0, T) defined as in Sect. 2.2.2. Let  $\{N_m\}_{m=1}^M$  be a collection of M independent realizations of the same Poisson process N on [0, T) with intensity function  $\lambda$ , and let  $\mathbb{X}_N = \{\mathbf{X}_m\}_{m=1}^M$  be a collection of Mindependent random vectors  $\mathbf{X}_m = (X_{m,i})_{i=0}^{2^{L+1}-1}$ , where  $X_{m,i} = N_m(s_i^{L+1})$  is the event count for process  $N_m$  in  $s_i^{L+1} \in S_{L+1}$ . With  $\hat{\beta}_{L,k} = \sum_{\tau_i \in \mathcal{E}} \psi_{L,k}(\tau_i)$ , for the Haar wavelets  $\hat{\beta}_{L,k} = \frac{2^{L/2}}{\sqrt{T}} (X_{m,2k} - X_{m,2k+1}), 0 \le k \le 2^L - 1$ . Each count  $X_{m,i}$  is distributed as Pois( $\mu_i$ ) where  $\mu_i = \int_{s_i^{L+1}} \lambda(t) dt$ . Therefore, the estimators  $\hat{\beta}_{L,k}$ ,  $k = 0, \dots, 2^L - 1$  are independent realizations of a scaled Skellam distribution (or Poisson difference distribution), each with parameters  $\mu_{2k}$  and  $\mu_{2k+1}$ . Since  $\hat{\beta}_{L,k}$  has mean  $\frac{2^{L/2}}{\sqrt{T}}(\mu_{2k} - \mu_{2k+1})$ , Definition 4 is then equivalent to the following property: "*There exists*  $k \in \{0, \dots, 2^L - 1\}$  such that  $\hat{\beta}_{L,k}$  is Skellam distributed with parameters  $\mu_{2k} \neq \mu_{2k+1}$ ". We can therefore build a likelihood ratio test for testing the null hypothesis H: " $\mu_{2k} = \mu_{2k+1}$  for all  $k = 0, \dots, 2^L - 1$ ".

Since there does not exist an explicit expression for the MLE of the parameter  $\theta_k = \mu_{2k} - \mu_{2k+1}$  given Skellam distributed random variables (instead having to be numerically approximated (Alzaid and Omair 2010)), it is more appealing to design a likelihood ratio test based on the event counts themselves. This leads us to first consider a LRT for the general setting of testing pairwise equality of means of Poisson distributions, which will then be used for the specific setting of testing *L*-th level innovation.

#### 3.4.1 LRT for pairwise equality of Poisson means

We define here a LRT for the pairwise equality of the means of a multivariate Poisson distribution. Let  $\mathbb{X} = \{\mathbf{X}_m\}_{m=1}^M$  be a set of iid Poisson random vectors, each with independent components of form  $\mathbf{X}_m = (X_{m,i})_{i=1}^{2P}$ ,  $X_{m,i} \sim \text{Pois}(\mu_i)$ . We consider testing the null hypothesis  $H : \mu_{2i-1} = \mu_{2i} = \mu_i^{pdir}$ ,  $1 \le i \le P$ , against the alternative hypothesis *K* that states *H* is not true. The LRT statistic is defined as

$$r = \frac{\sup_{\{\mu_i^{pair}\}_{i=1}^{p}, \sum \mu_i^{pair} > 0} \mathcal{L}(\mathbb{X}; \mu_1^{pair}, \mu_1^{pair}, \dots, \mu_p^{pair}, \mu_p^{pair})}{\sup_{\{\mu_i\}_{i=1}^{2p}, \sum \mu_i > 0} \mathcal{L}(\mathbb{X}; \mu_1, \mu_2, \dots, \mu_{2P-1}, \mu_{2P})},$$
(9)

where  $\mathcal{L}(X;\mu_1,\ldots,\mu_{2P})$  is the likelihood of the data X given parameter vector  $(\mu_i)_{i=1}^{2P}$ .

**Proposition 4** Let  $R = -2 \log(r)$ , with *r* being the likelihood ratio statistic defined in (9). Then

$$R = 2M\left[\sum_{i=1}^{P} \bar{\mu}_{2i-1} \log\left(\frac{\bar{\mu}_{2i-1}}{\bar{\mu}_{i}^{pair}}\right) + \sum_{i=1}^{P} \bar{\mu}_{2i} \log\left(\frac{\bar{\mu}_{2i}}{\bar{\mu}_{i}^{pair}}\right)\right],$$

where  $\bar{\mu}_i = \frac{1}{M} \sum_{m=1}^M X_{m,i}$  and  $\bar{\mu}_i^{pair} = \frac{1}{M} \sum_{m=1}^M \hat{\mu}_{m,i}^{pair}$  where  $\hat{\mu}_{m,i}^{pair} = \frac{1}{2} (X_{m,2i-1} + X_{m,2i})$ . Statistic  $\bar{\mu}_i^{pair}$  is the maximum likelihood estimator (MLE) of  $\mu_i^{pair}$  (i = 1, ..., P) under the null hypothesis H and  $\bar{\mu}_i$  is the MLE for  $\mu_i$  (i = 1, ..., 2P) under the alternative hypothesis K.

The proof can be found in Supplementary Material S2.5. From Wilks' Theorem (Wilks 1938), we immediately have that under the null hypothesis *R* is asymptotically  $\chi^2$  distributed with  $d_K - d_H = P$  degrees of freedom for a large sample size *M* (under the usual regularity assumptions). However, this result is not guaranteed when the true parameter vector lies on the boundary of the parameter space. This was not the case

for the test in Sect. 3.2.1 since we must have  $\mu_c > 0$ , although it happens in this model when  $\mu_i^{pair} = 0$ . Further discussion on this particular case can be found in Supplementary Material S1.1. We now assume that  $\mu_i^{pair} \neq 0$  for all  $1 \le i \le P$ . Similar to Theorem 1, we can state an extension of Wilks' theorem for this LRT.

**Theorem 2** Let  $\mathbf{X}_1, \ldots, \mathbf{X}_M$   $(M \ge 1)$  be independent and identically distributed 2P dimensional random vectors where each  $\mathbf{X}_m = (X_{m,1}, \ldots, X_{m,2P})^T$  is constructed from independent components  $X_{m,i} \sim \operatorname{Pois}(\mu_i)$ . Let  $R = -2\log(r)$  where r is the like-lihood ratio statistic defined in (9). Then the distribution of statistic R is invariant to simultaneous changes in parameters M and  $\mu_i$  provided all products  $\mu_i M$ ,  $1 \le i \le 2P$  remain constant. Furthermore, if  $\mu_{2i-1} = \mu_{2i} = \mu_i^{pair}$  and  $\mu_i^{pair} \ne 0$ ,  $1 \le i \le P$ , then  $R \rightarrow \chi_P^2$  as  $\mu_i^{pair} M \rightarrow \infty$ ,  $1 \le i \le P$ .

The proof of Theorem 2 follows an analogous argument to that of Theorem 1 (see Supplementary Material S2.7). We again prove that in the asymptotic analysis of the distribution of R, M and the mean intensity are indistinguishable from their product, and thus, the results are applicable for only one realization of the random vector **X**.

#### 3.4.2 LRT for L-th level innovation

We can now apply the test developed in Sect. 3.4.1 to the task of testing *L*-th level innovation. The LRT statistic for testing the null hypothesis *H*: " $\mu_{2k} = \mu_{2k+1}$  for all  $k = 0, ..., 2^L - 1$ " is

$$r^{L} = \frac{\sup_{\left\{\mu_{k}^{pair}\right\}_{k=0}^{2^{L}-1}, \sum \mu_{k}^{pair} > 0} \mathcal{L}(\mathbb{X}; \mu_{0}^{pair}, \mu_{0}^{pair}, \dots, \mu_{2^{L}-1}^{pair}, \mu_{2^{L}-1}^{pair})}{\sup_{\left\{\mu_{k}\right\}_{k=0}^{2^{L+1}-1}, \sum \mu_{k} > 0} \mathcal{L}(\mathbb{X}; \mu_{0}, \dots, \mu_{2^{L+1}-1})}$$

From Proposition 4, we have:

$$R^{L} = -2\log(r^{L}) = 2M \left[ \sum_{k=0}^{2^{L}-1} \bar{\mu}_{2k} \log\left(\frac{\bar{\mu}_{2k}}{\bar{\mu}_{k}^{pair}}\right) + \sum_{k=0}^{2^{L}-1} \bar{\mu}_{2k+1} \log\left(\frac{\bar{\mu}_{2k+1}}{\bar{\mu}_{k}^{pair}}\right) \right].$$

Again, we refer to Supplementary Material S1.1 in the situation where one or several parameters  $\mu_k^{pair}$  are equal to zero. In all other cases, we have  $d_K = 2^{L+1}$  and  $d_H = 2^L$ , giving *R* as asymptotically  $\chi^2$  distributed with  $2^L$  degrees of freedom under the conditions of Theorem 2. We reject the absence of a level *L* innovation at significance level  $\alpha$  if  $R > c_{\alpha}$  where  $c_{\alpha}$ , the critical value, is the upper  $100(1 - \alpha)\%$  point of the  $\chi^{2L}_{2L}$  distribution.



**Fig. 5** *Left:* Triangular rate on [0, 1] with mean  $\lambda_0 = 1000$ , V = 1,  $\xi = 0.1$  and an additive sine perturbation with v = 3 and magnitude A = 0.05. *Right:* Empirical type 1 error (L = 1) and power plots ( $L \in \{3, 4, 5\}$ ) as a function of  $\lambda_0$  with T = 1, V = 1,  $\xi = 0.1$  and A = 0.05. See text in Sect. 3.4.3 for further details

#### 3.4.3 Simulation study

Let us now consider the triangular intensity model from Sect. 3.2.3 where we now introduce an additive perturbation in the form of a sine function with period  $T/2^{\nu}$ ,  $\nu \ge V + 3$ , and magnitude  $A\lambda_0$ . Again, *T* is the length of the process and  $\lambda_0$  is the mean value of the rate. Therefore, this intensity model has expression

$$\lambda_{\rm sine}(t) = \lambda_0 \left( 1 + (-1)^{i(t)} \xi \left( \theta(t) - \frac{1}{2} \right) \right) + A \lambda_0 \sin \left( \frac{2^{\nu+1} \pi}{T} t \right).$$

Similar to the previous model, the quantity  $\mu_0^0 = \int_0^T \lambda_{sine}(t)dt = T\lambda_0$  does not depend on *V*, the process is level *V* + 1 homogeneous and level *V* + 2 inhomogeneous. The sinusoidal term does not influence the values of the wavelets coefficients up to resolution *v*. Hence a Poisson process *N* whose intensity is  $\lambda_{sine}$  possesses no innovations from levels 0 to *V*, *V* + 1 innovation is introduced by the triangular part and another source of innovation is introduced at level *v* from the sinusoidal term. The power of the test is studied for  $L \ge v$ . An example plot is given in Fig. 5.

We set the significance level of our test at  $\alpha = 0.05$ , with M = 1 and  $\lambda_0 \in [1000, 50,000]$  as in the LRT for J-th level homogeneity. The empirical type 1 error and power plots from 10,000 simulations are shown in Fig. 5 for L = 1(type 1 error in the absence of innovation) and L = 3, 4 and 5 (power in the presence of innovation). We are interested in exploring the effects of the parameter  $\lambda_0$ on the empirical type 1 error and power of the LRT for the absence of L-th level innovation. Again the empirical type 1 error lies close to the 5% level as expected when the conditions of Theorem 2 are met. We also observe that the empirical power converges to 1 as the magnitude of the perturbation increases through the product  $A\lambda_0$ . Since the intensity model is still proportional to  $\lambda_0$ , this is also justified from Theorem 2 as the equivalent behaviour is expected when  $\lambda_0$  is fixed and M increases towards infinity. Furthermore, it is noticeable that for a fixed  $\lambda_0$ , the power decreases as we increase L. This can be explained because increasing L displaces the mass of the null distribution  $\chi^2_{\gamma L}$  further to the right, making it harder for the test to distinguish between the null hypothesis and the true state of nature.

$$\widehat{\mathbf{B}}^{L} = \begin{pmatrix} \widehat{\beta}_{L,1}^{(1)} & \widehat{\beta}_{L,2}^{(1)} & \widehat{\beta}_{L,3}^{(1)} & \widehat{\beta}_{L,4}^{(1)} \\ \vdots & \vdots & \vdots & \vdots \\ \widehat{\beta}_{L,1}^{(m)} & \widehat{\beta}_{L,2}^{(m)} & \widehat{\beta}_{L,3}^{(m)} & \widehat{\beta}_{L,4}^{(m)} \\ \vdots & \vdots & \vdots & \vdots \\ \widehat{\beta}_{L,1}^{(M)} & \widehat{\beta}_{L,2}^{(M)} & \widehat{\beta}_{L,3}^{(M)} & \widehat{\beta}_{L,4}^{(M)} \end{pmatrix} \Longrightarrow \widehat{\mathbf{\Theta}}^{L} = \mathcal{T}(\widehat{\mathbf{B}}^{L}) = \begin{pmatrix} \widehat{\beta}_{L,1}^{(1)} & 0 & \widehat{\beta}_{L,3}^{(1)} & 0 \\ \vdots & \vdots & \vdots & \vdots \\ \widehat{\beta}_{L,1}^{(m)} & 0 & \widehat{\beta}_{L,3}^{(m)} & 0 \\ \vdots & \vdots & \vdots & \vdots \\ \widehat{\beta}_{L,1}^{(M)} & \widehat{\beta}_{L,2}^{(M)} & \widehat{\beta}_{L,3}^{(M)} & \widehat{\beta}_{L,4}^{(M)} \end{pmatrix}$$

**Fig. 6** Example output of a thresholding operator with  $\mathcal{K}_L = \{1, 2, 3, 4\}$ 

# 4 Statistical thresholding

As stated in Sect. 2.2, we can define a nonlinear wavelet estimator of the intensity of a point process when a thresholding strategy is applied on the coefficient estimates. We initially define a general formulation for thresholding strategies in intensity estimation that we can adapt to different examples. To define a thresholding strategy, we need to choose a wavelet family for the estimation of the corresponding coefficients and a threshold operator that will be applied on the data. We consider a collection of compactly supported mother wavelets  $\{\Psi_{L,k}, k \in \mathcal{K}_L\}$ , where  $\mathcal{K}_L$  is the ordered finite subset of  $\mathbb{Z}$  containing the translation indexes of the wavelets that are used as a basis for  $W_L$ , and further denote  $K_L = |\mathcal{K}_L|$ . For instance  $\mathcal{K}_L = \{0, \dots, 2^L - 1\}$  under the Haar basis if the intensity has support [0, 1) or [0, T) with rescaled wavelets. Let  $\{N_m, m = 1, \dots, M\}, M \ge 1$ , be a collection of independent realizations of the same point process N, we define  $\hat{\mathbf{B}}^L = (b_{m,i}) \in \mathbb{R}^{M \times \mathcal{K}_L}$ , where  $b_{m,i} \equiv \hat{\beta}_{L,k_i}^{(m)}$  is the estimator of the true wavelet coefficient  $\beta_{L,k}$  obtained from  $N_m$ .

the true wavelet coefficient  $\beta_{L,k_i}$  obtained from  $N_m$ . We represent a thresholding operator  $\mathcal{T} : \mathbb{R}^{M \times K_L} \to \mathbb{R}^{M \times K_L}$  with  $\widehat{\Theta}^L = \mathcal{T}(\widehat{\mathbf{B}}^L)$  being the output where each column of  $\widehat{\Theta}^L$  is the corresponding column of  $\widehat{\mathbf{B}}^L$  if a thresholding criterion *C* is met, or a column of zeros if *C* is not met (see illustration in Fig. 6). If the *i*-th column of  $\widehat{\mathbf{B}}^L$  meets the criterion *C* and is therefore kept by the operator  $\mathcal{T}$ , then the estimator of  $\beta_{L,k_i}$  used in the final reconstruction of  $\lambda$  will be the sample mean  $\frac{1}{M} \sum_{m=1}^{M} \widehat{\beta}_{L,k_i}^{(m)}$ . A thresholding operator is applied between coarse and fine limits  $j_0$  and *J*, respectively, resulting in a filtering of the information contained in the detail spaces  $W_j, j_0 \leq j \leq J$ . The effect of different choices for  $j_0$  and *J* is explored in Appendices in ESM. Defining the  $\mathbb{R}^{K_L}$  vector  $\Psi_L(t) = (\Psi_{L,k_1}(t), \dots, \Psi_{L,k_{K_L}}(t))^T$ , where  $k_1$  and  $k_{K_L}$  are, respectively, the first and last elements of the index set  $\mathcal{K}_L$ , and  $\mathbf{1}_M = (1, \dots, 1)^T$  the vector of ones of length *M*, the nonlinear estimator can be formulated as

$$\hat{\lambda}_{\mathcal{I}}^{J}(t) = \frac{1}{M} \sum_{m=1}^{M} \sum_{k_{i} \in \mathcal{K}_{j_{0}}} \hat{\alpha}_{j_{0},k_{i}}^{(m)} \phi_{j_{0},k_{i}}(t) + \frac{1}{M} \sum_{L=j_{0}}^{J} \mathbf{1}_{M}^{T} \widehat{\boldsymbol{\Theta}}^{L} \Psi_{L}(t) .$$
(10)

Similar to the distinction made in Härdle et al. (1998) for density estimation, we define three procedures for thresholding. We are applying local thresholding if criterion *C* considers each column of  $\hat{\mathbf{B}}^L$  separately, global thresholding if *C* considers the entire matrix  $\hat{\mathbf{B}}^L$ , and intermediate thresholding for other cases where *C* considers subsets of columns. The criteria *C* that we will propose here are based on variations of the previously defined *L*-th level innovation hypothesis test formulated in Sect. 3.4.2, and in doing so we assume that the conditions of Theorem 2 are always met for all  $j_0 \leq L \leq J$ . Our thresholding strategies hence take the form of multiple hypothesis tests as ignoring this specificity could lead to a high number of truly zero coefficients to be kept in the reconstruction of  $\lambda$ .

When M = 1, a common setting,  $\widehat{\mathbf{B}}^L$  and  $\widehat{\mathbf{\Theta}}^L$  become row vectors with the *i*-th element of  $\widehat{\mathbf{\Theta}}^L$  being  $\widehat{\beta}_{L,k_i}(1 - \mathbb{1}_{[-\delta_{k_i},\delta_{k_i}]}(\widehat{\beta}_{L,k_i}))$ , where  $\delta_{k_i} \ge 0, i = 1, ..., K_L$ , are threshold levels that need to be chosen. de Miranda and Morettin (2011) propose  $\delta_{k_i} = \omega \sqrt{\operatorname{Var}(\widehat{\beta}_{L,k_i})}$ , with  $\omega$  typically equal to 3. This requires a crude estimator of the variance of the coefficient estimators. The authors notice an equivalence between this method and using  $\widehat{\beta}_{L,k_i}$  as a test statistic for the null hypothesis  $\beta_{L,k_i} = 0$ . This employs Chebyshev's inequality and works on the assumption that  $\widehat{\beta}_{L,k_i}$  is approximately Gaussian. This parallel is interesting enough for us to use this thresholding operator as a comparison point in our simulations.

#### 4.1 Local thresholding with false discovery rate control

Under this thresholding procedure, we apply a hypothesis test to each coefficient with the null hypothesis being that this coefficient is zero. In the case of Haar wavelets, the LRT for *L*-th level innovation defined in Sect. 3.4.2 can be reduced to the case of a single coefficient without any change to its asymptotic properties. In particular, the reduced null hypothesis is now  $H_{0,k}^{L,k}$ :" $\beta_{L,k} = 0$ " or equivalently " $\mu_{2k} = \mu_{2k+1}$ ", for any  $k \in \{0, ..., 2^L - 1\}$  and  $j_0 \le L \le J$ .

Using a local thresholding operator with Haar wavelets requires a total of  $Q = 2^{J+1} - 2^{j0}$  hypothesis tests for coarse and fine resolution scales  $j_0$  and J, respectively. For this thresholding scheme, the criterion C considers individually the pvalue of each test. A naive criterion C is that the coefficient is kept if the p value for the corresponding test is lower than some fixed significance level  $\alpha$ . However, in this case too few coefficients might be thresholded. The other approach that we explore here follows the statistical thresholding method of Abramovich and Benjamini (1995) which is based on the False Discovery Rate (FDR) defined in Benjamini and Hochberg (1995). Of the Q hypotheses being tested, we say that  $Q_0$  are true null hypotheses and the total number of rejected hypotheses is R, of which F are falsely rejected. Note that  $Q_0$  and F are unknown quantities. The FDR is the expectation of the ratio F/R, and is the quantity we look to control. Since the FDR approach to multiple testing produced lower mean squared errors compared to the universal hard threshold for certain types of signals in Abramovich and Benjamini (1995), it seems natural to carry it over to the Poisson intensity estimation model. This method positions itself between the naive approach where the error is only controlled at the very local level (coefficient-wise) and more constrained approaches like Bonferroni's correction where the error is instead simultaneously controlled among all tests (the family-wise error rate), with the latter being prone to power loss.

This procedure assumes independence of at least the  $Q_0$  test statistics associated with the true null hypotheses. Under that setting the FDR is controlled by  $\alpha$ , a global significance level. Since our Poisson intensity estimation model introduces dependence (between scales) among the test statistics, Benjamini and Yekutieli (2001) demonstrate that a conservative modification of  $\alpha$  to  $\alpha_Q = \alpha/(\sum_{i=1}^Q \frac{1}{i})$  allows us to extend the FDR control method for any joint distribution of the test statistics. The FDR is then bounded by  $(Q_0/Q)\alpha$  which is lower than  $\alpha$ . Now, the thresholding procedure is as follows:

- 1. Determine the *p* values  $p_{L,k}$  of the LRT for the null hypothesis of each coefficient  $H_0^{L,k}$ : " $\beta_{L,k} = 0$ ", for all  $j_0 \le L \le J$  and  $k \in \mathcal{K}_L$  and sort them by increasing value to obtain the ordered indexed set  $\mathcal{P} = \{p_1, \dots, p_Q\}$ , where *Q* is the total number of tests considered in the thresholding range. Note that *Q* does not depend on *M*.
- 2. For a given significance level  $\alpha$ , find the largest index *i* that satisfies  $p_i \leq (i/Q)\alpha_Q$ where  $\alpha_Q = \alpha/(\sum_{i=1}^Q \frac{1}{i})$ .
- 3. Criterion C states that the coefficients corresponding to the p values smaller than or equal to  $p_i$  are kept.

#### 4.2 Global thresholding with Holm–Bonferroni correction

The global thresholding strategy is based on the exact L-th level innovation test defined in Sect. 3.4.2. In this circumstance, we test each level j,  $j_0 \le j \le J$  with a single test. The total number of tests is now  $Q = J - j_0 + 1$ , significantly decreasing computational time when compared to the local thresholding method. Again, several approaches can be considered to control the multiplicity of errors arising from combining the results of multiple tests. One thing to notice is that swapping multiple univariate tests for a single multivariate test at each level L is already a way to address multiple hypothesis testing in this context. This choice reflects an emphasis on the detection of any significant information inside the detail space  $W_L$  regardless of its temporal location. This makes the thresholding easier to control statistically but may lead to an unnecessary number of coefficients kept in the end. Now since the number of tests here is linear with the maximum resolution J and thus limited in practice, the Holm-Bonferroni method (Holm 1979), which is a uniformly more powerful method than Bonferroni correction, can be reasonably considered. Another interesting thing here is that Holm-Bonferroni correction does not require independence of the test statistics. Now, the procedure to determine the criterion C is the following:

1. Determine the *p* value of the LRT for each null hypothesis  $H_0^L$ : "there is no *L*-th level innovation",  $j_0 \le L \le J$ , and sort them by increasing value to obtain the ordered indexed set  $\mathcal{P} = \{p_1, \dots, p_Q\}$ , where *Q* is the total number of tests considered in the thresholding range. Again *Q* does not depend on *M*.

- 2. From a given significance level  $\alpha$ , find the minimal index *i* that satisfies  $p_i > \frac{\alpha}{O+1-i}$ . Denote this index  $i_m$ .
- 3. Accept the null hypotheses with p values indexed from 1 to  $i_m 1_{n}$
- 4. Criterion *C* states that if the null hypothesis  $H_0^L$  is accepted, then  $\widehat{\Theta}^L = 0$ , otherwise  $\widehat{\Theta}^L = \widehat{\mathbf{B}}^L$ .

Using Holm-Bonferroni's correction, the family-wise error rate of this global thresholding strategy, which is the probability or having at least one type 1 error for an individual test, is always less or equal to the given significance level  $\alpha$ .

#### 4.3 Intermediate thresholding based on recursive tests

The intermediate thresholding strategy uses the recursive testing approach proposed in Ogden and Parzen (1996). This method falls into the intermediate category since the number of coefficients tested together to determine Criterion *C* varies between 1 and  $K_L = |\mathcal{K}_L|$  for each resolution level *L*. The procedure is the same at each level  $j_0 \le L \le J$ , and is as follows:

- 1. Test the null hypothesis  $H_0^L$  :  $\beta_{L,k} = 0$  for all  $k \in \mathcal{K}_L$  using the LRT at significance level  $\alpha$ .
- 2. If the null is rejected, find the index  $i \in \mathcal{K}_L$  such that the sample mean  $\frac{1}{M} \sum_m \hat{\beta}_{L,i}^{(m)}$  has the largest absolute value. Remove the *i*-th component in the null hypothesis  $H_0^L$  to form a new null hypothesis  $H_0^{L,-i}$ .
- 3. Repeat steps 1 and 2 until the null is not rejected. Criterion *C* retains all the coefficients that have been removed from the original null hypothesis.

#### 4.4 Simulation study

This study aims to compare the accuracy of different thresholding strategies by applying them on three Poisson process models on [0, 1] with intensities that exhibit different behaviours and regularities. The chosen measures of accuracy are the mean root integrated squared error (MRISE) which is defined as

$$\mathbf{E}\left[\left(\int (\widehat{\lambda}^{J}(t) - \lambda(t))^{2} \mathrm{d}t\right)^{1/2}\right],$$

and the mean integrated absolute error (MIAE) which is defined as

$$\mathbf{E}\left[\int \mid \hat{\lambda}^{J}(t) - \lambda(t) \mid \mathrm{d}t\right].$$

We estimate the MRISE and the MIAE with

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$$\widehat{MRISE} = \frac{1}{n} \sum_{i=1}^{n} \left( \frac{1}{m} \sum_{j=1}^{m} \left( \widehat{\lambda}_{i}^{J}(t_{j}) - \lambda(t_{j}) \right)^{2} \right)^{1/2}$$

and

$$\widehat{MIAE} = \frac{1}{n} \sum_{i=1}^{n} \left( \frac{1}{m} \sum_{j=1}^{m} | \hat{\lambda}_{i}^{J}(t_{j}) - \lambda(t_{j}) | \right).$$

In this study, we use n = 10,000 repeat simulations and  $t_j = (j - 1)/m$  where m = 1000. The first two intensity models are based on the "*Blocks*" and "*Bumps*" test functions from Donoho and Johnstone (1994). The third function is a modification to that defined in Sect. 3.4.3. We will refer to this model as "*TriangleSine*" and it has expression

$$f_{\text{tsine}}(t) = \lambda_0 \left( 1 + (-1)^{i(t)} \xi \left( \theta(t) - \frac{1}{2} \right) + A \sin \left( \frac{2^{L+1} \pi}{T} t + \frac{1}{T} \right) \right),$$

where  $i(t) \in \{0, \dots, 2^{V+1} - 1\}$  is the index of the subinterval  $s_{i(t)}^{V+1} = [\frac{i(t)}{2^{V+1}}T, \frac{i(t)+1}{2^{V+1}}T)$  in which *t* belongs, and  $\theta(t)$  is defined by  $t = (i(t) + \theta(t))T/2^{V+1}$ .

We set T = 1 and rescale these functions so that their integral on [0, 1] are equal. Further, since the "*Blocks*" function can take negative values, we apply an upwards shift such that it is positive. The resulting intensities are

$$\begin{split} \lambda_{\text{blocks}}(t) =& 1.75A_0 + 0.25A_0 \frac{f_{\text{blocks}}(t)}{\int_0^1 f_{\text{blocks}}} \\ \lambda_{\text{bumps}}(t) =& 1.75A_0 + 0.25A_0 \frac{f_{\text{bumps}}(t)}{\int_0^1 f_{\text{bumps}}} \\ \lambda_{\text{tsine}}(t) =& A_0 + A_0 \frac{f_{\text{tsine}}(t)}{\int_0^1 f_{\text{tsine}}}. \end{split}$$

We are therefore ensuring that  $E\{N(1)\}$  is always equal to  $2A_0$  for the three Poisson process models. The value of  $A_0$  determines the highest resolution at which we can threshold the Haar wavelet coefficients. From the conditions of Theorem 2, the minimum value of the set  $\{M\mu_i = M \int_{s_i^{J+1}} \lambda(t) dt, i = 0, ..., 2^{J+1} - 1\}$  should be high enough (for instance, greater than or equal to 50) for reliable likelihood ratio tests for *L*-th level innovation up to level *J* (and for smaller groups of wavelet coefficients in local and intermediate thresholding). Since we are demonstrating the presented methods for the M = 1 case this imposes that the minimum value of  $\{\mu_i, i = 0, ..., 2^{J+1} - 1\}$  is greater than or equal to 50.

We now compare the MRISE and MIAE on these three intensity models for five thresholding strategies: statistical local, intermediate and global thresholding, as well as no thresholding (linear estimation) and the hard local thresholding of de Miranda and Morettin (2011). This study is restricted to continuous estimation of



Fig. 7 Averaged reconstruction of the three intensity models "Blocks", "Bumps" and "TriangleSine", with  $A_0 = 10,000, j_0 = 3, J = 7, M = 1$  and significance level  $\alpha = 0.05$ . The true intensity is in blue, and the reconstruction is in red (colour figure online)

<b>Table 1</b> R-MRISE and R-MIAE values with $A_0 = 10,000, j_0 = 3, J = 7, M = 1$ and significance level $\alpha = 0.05$		Linear	DM-L	LRT-L	LRT-I	LRT-G
	Blocks R-MRISE	1	0.6455	0.6937	0.6402	0.7701
	Blocks R-MIAE	1	0.5156	0.5778	0.5107	0.7367
	Bumps R-MRISE	1	1.0099	1.0538	0.9659	0.9996
	Bumps R-MIAE	1	0.7632	0.7974	0.7201	1
	TriangleSine R-MRISE	1	0.6887	0.6544	0.6747	0.6000
	TriangleSine R-MIAE	1	0.7448	0.7224	0.7079	0.6008

The number in bold indicates the best-performing method

the intensity and M = 1 as we want to compare methods in a practical context. We included the linear estimation as it serves as a reference point and is also the M = 1case for the methods presented in Revnaud-Bouret and Rivoirard (2010) and Bigot et al. (2013). We aim to study the influence of four parameters on this accuracy ranking: the starting resolution level  $j_0$ , the maximum resolution level J, the significance level  $\alpha$  and the value of  $A_0$ . In Table 1, we provide the relative MRISE (R-MRISE) and relative MIAE (R-MIAE) values for one scenario where the estimated MRISE and MIAE for each thresholding strategy is divided by the value under absence of thresholding, which serves as a reference point. We refer to the method of de Miranda and Morettin (2011) as "DM-L" and our three statistical thresholding strategies as "LRT-L", "LRT-I" and "LRT-G" for the local, intermediate and global

thresholding methods, respectively. Intensity reconstructions averaged over 10,000 simulations are shown in Fig. 7 under the same setting and for all thresholding procedures as well. Bootstrapped 95% confidence intervals for the MRISE and the MIAE, plus further simulation studies, can be found in Supplementary Material S3.

The first conclusion in the setting of Table 1 is that we have statistical evidence that for all three intensity models at least one of LRT-I or LRT-G performs better than the linear and DM-L strategies. The statistical validity of this ranking relies on the absence of overlap between the 95% confidence intervals for the MRISE and MIAE of each method, as shown in Supplementary Material S3 Table 1. LRT-G performs better when innovations are well spread across time, whereas LRT-I leads in the case of abrupt changes. The same ranking is obtained when using the MIAE as an error measure, which gives consistency to the results. This was expected from the design of each strategy. For instance, the "Blocks" intensity has a sparse Haar wavelet decomposition with nonzero mother wavelets coefficients at high resolutions localized at the jumps. Therefore, this model favours LRT-L and LRT-I. Figure 7 shows the mean intensity estimate against the true intensity and therefore illustrates bias. We note as expected that the linear estimator is unbiased, although it has high variance which is accounted for in the MRISE. The improvement from the linear estimation is more significant for the "Blocks" and "Bumps" intensity models when the MIAE is used as an error measure. This is due to the MRISE giving more penalization to noisy estimators at higher resolutions than the MIAE.

# 5 Application to NetFlow data

We apply the methodology presented in this paper to NetFlow data from a single router on the Imperial College London network. This data consists of  $1.566 \times 10^8$  event times, each corresponding to the time a flow was sent or received by the router. The data was collected over a single 24-h period that starts and ends at midnight. We therefore assume this to be a single realization (M = 1) of an underlying Poisson process that may or may not be homogeneous. In Sect. 4.4, to give validity to our approach, we proposed that the minimum event count across the half-support of a Haar wavelet at the highest level of resolution J should be at least 50. In the following data analysis, we consider up to scale J = 10, at which the minimum event count is  $5.9035 \times 10^4$ . This puts us well within the setting where asymptotic distributions derived in this paper can be assumed and the power of the tests within the thresholding mechanism are high.

We start with testing level-1 homogeneity for which we obtain a *p* value less than  $10^{-300}$  indicating strong evidence to reject homogeneity. We also strongly reject the absence of level-*L* innovation for all levels between 1 and 10, with *p* values again less than  $10^{-300}$  in all cases. This indicates an underlying intensity function which is rapidly varying across even very small timescales (~ 1 min). In Fig. 8, we plot reconstructions of the intensity for different values of *J* using the LRT-I method with  $j_0 = 3$  and  $\alpha = 0.05$ . From the simulation study in Supplementary Material S3, this method is preferred as it performed consistently well under this choice of parameters. Analysing at J = 4 shows broad trends in network activity, including both



**Fig.8** Reconstruction of the NetFlow intensity with LRT-I, using parameters  $j_0 = 3, J \in \{4, 6, 8, 10\}, M = 1$  and significance level  $\alpha = 0.05$ 

human behavioural habits and general automated processes on the network. Specifically, between 03:00 and 07:00 the high activity through the router corresponds to automated system tasks, predominantly the backing up of servers. Human activity is then likely to be responsible for increasing activity from 09:00 until late afternoon. NetFlow traffic then decreases from 18:00 until midnight as human activity on the network gradually decreases. The analysis of J = 4 and J = 6 reveal interesting spikes in activity at around 18:00 and 21:00. The spike at 18:00, for example, is likely to be a flurry of activity before people leave to go home. As we move up to scales 8 and then 10 we reveal regular, pronounced spiking in the activity on the network. Further analysis reveals these to be all of similar magnitudes and at regular 15-min intervals. Routers are designed to manage their memory, which means that, at regular intervals, it will close some open flows, and start them again. Typical manufacturer choices for these intervals are 5, 10 or 15 min. This analysis would indicate 15 min for this particular router.

Our ability to be able to detect and characterize network behaviour in this multiscale fashion has potential usage in cyber-security applications where the characterization of "normal" network activity is key to being able to detect anomalous and potentially malicious activity.

#### 6 Conclusion

The wavelet analysis of point processes in continuous time has been addressed through wavelet expansions of the first-order intensity. By defining a Haar wavelet multiresolution analysis on the point process, new multiscale properties, namely J-th level homogeneity and L-th level innovation, were introduced and tests for them formulated. Importantly, these tests can be applied when only a single realization of the process is observed. Tests for L-th level innovation formed the framework with which to perform thresholding of wavelet coefficients for intensity estimation.

The mean root integrated squared error and mean integrated absolute error of these methods were compared on simulated data for three different intensity models, revealing different accuracy rankings depending on the model. An important point here is that no thresholding method uniformly outperforms all others-although at least one of the statistical thresholding (LRT) methods outperforms the existing local hard thresholding method (DM-L) in all but one of the scenarios studied (see Supplementary Material S3). This seems reasonable and is consistent with the study of Antoniadis et al. (2001) for wavelet regression and Besbeas et al. (2004) for discrete time Poisson intensity estimation. The rule of thumb we offer is that LRT-G outperforms the other methods for intensity functions that exhibit smooth, largescale changes in time. For intensity functions that exhibit abrupt, localized changes (i.e. possess a sparse wavelet representation), LRT-L and LRT-I strategies are to be preferred. It has been demonstrated that LRT-I thresholding when applied to Net-Flow data exposes different behaviour at different scales, and that this can be attributed with various human and automated activities. This illustrates the benefit and insight gained from a multiscale approach to analysing point processes.

How to go about choosing the free-parameters  $\alpha$ ,  $j_0$  and J in a data-driven way still needs to be addressed. The development of cross-validation schemes in the point process setting would make an interesting extension but falls outside the scope of this paper. Extensions of the presented theory and methodology can now be considered for the second-order intensity and multidimensional point processes.

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#### **Compliance with ethical standards**

Conflict of interest The authors declare that they have no conflict of interest.

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